

INFORMATION DISCLOSURE CITATION

Atty. Docket No.	04329.3161	Serial No.	Not Yet Assigned
Applicants	Kenji KAWANO et al.		
Filing Date	October 10, 2003	Group:	Not Yet Assigned

U.S. PATENT DOCUMENTS							
Examiner Initial*		Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate
Stf		6,265,696	07/24/01	SAKURAI et al.			
		6,301,435	10/09/01	ITO et al.			
		6,333,493	12/25/01	SAKURAI et al.			
Stf		6,550,990	04/22/03	SAKURAI et al.			

FOREIGN PATENT DOCUMENTS							
		Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No
Stf		11-038644	02/12/99	JAPAN			ABSTRACT
Stf		2000-146444	05/26/00	JAPAN			ABSTRACT

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)	
Stf	KAWANO, K. et al., "Apparatus For Processing Substrate and Method of Processing The Same", U.S. Patent Application No. 10/026,419, filed December 26, 2001.
Stf	KIHARA, N. et al., "Effect of Acid Evaporation in Chemically Amplified Resists on Insoluble Layer Formation", Journal of Photopolymer Science and Technology, Vol. 8, No. 4, pp. 561-569, (1995).

Examiner	Shauntina Lugo	Date Considered	4/11/05
*Examiner:	Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		
Form PTO 1449	Patent and Trademark Office - U.S. Department of Commerce		

INFORMATION DISCLOSURE CITATION

Atty. Docket No. 4329.3161	Appln. No. 10/682,419
Applicant Kawano et al.	
Filing Date October 10, 2003	Group: 2812

U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate

FOREIGN PATENT DOCUMENTS

	Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No
34	2002-252167	9/6/02	Japan	—	—	
34	6-124873	5/6/94	Japan	—	—	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner <i>Shawntina Suggs</i>	Date Considered <i>4/11/05</i>
---------------------------------	--------------------------------

*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.